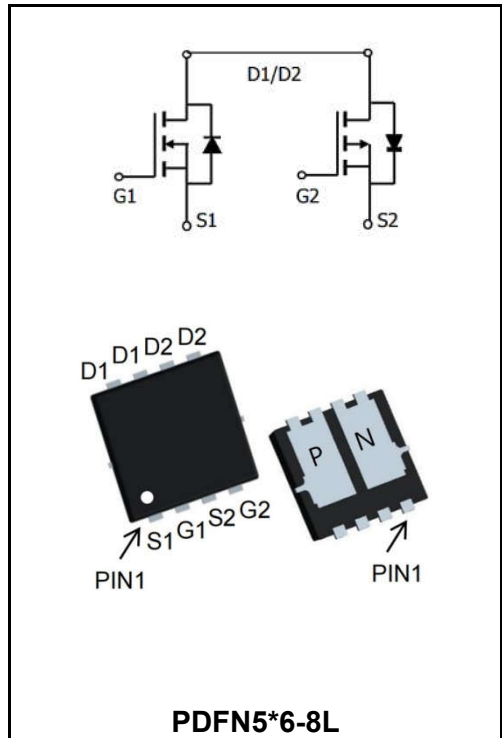


**30V N+P-CHANNEL ENHANCEMENT MODE MOSFET**

**MAIN CHARACTERISTICS**

$I_D$	42A
$V_{DSS}$	30V
$R_{DS(on)-typ}(@V_{GS}=10V)$	< 10mΩ (Type: <b>6.5 mΩ</b> )
$I_D$	-38A
$V_{DSS}$	-30V
$R_{DS(on)-typ}(@V_{GS}=-10V)$	< 13mΩ (Type: <b>9.0 mΩ</b> )



**Application**

- ◆ Wireless charging
- ◆ Boost driver
- ◆ Brushless motor

**Product Specification Classification**

Part Number	Package	Marking	Pack
YFW40G03NF	PDFN5*6-8L	YFW 40G03NF XXXXX	5000PCS/Tape

**Maximum Ratings at Tc=25°C unless otherwise specified**

Characteristics	Symbols	Value		Units
		N-Ch	P-Ch	
Drain-Source Voltage	$V_{DS}$	30	-30	V
Gate - Source Voltage	$V_{GS}$	±20	±20	V
Continuous Drain Current, $V_{GS} @ 10V^1 @ T_c=25^\circ C$	$I_D$	42	-38	A
Continuous Drain Current, $V_{GS} @ 10V^1 @ T_c=100^\circ C$	$I_D$	32.5	-27.5	A
Pulsed Drain Current <sup>2</sup>	$I_{DM}$	123	-115	A
Single Pulse Avalanche Energy <sup>3</sup>	$E_{AS}$	289	378	mJ
Avalanche Current	$I_{AS}$	42	50	A
Total Power Dissipation <sup>4</sup> @ $T_c=25^\circ C$	$P_D$	46	41.3	W
Storage Temperature Range	$T_{STG}$	-55 to +150		°C
Operating Junction Temperature Range	$T_J$	-55 to +150		°C
Thermal Resistance Junction-Ambient <sup>1</sup>	$R_{\theta JA}$	25		°C/W
Thermal Resistance Junction-Case <sup>1</sup>	$R_{\theta JC}$	2.3		°C/W

**N-Channel Electrical Characteristics (T<sub>J</sub>=25 °C, unless otherwise noted)**

Characteristics	Test Condition	Symbols	Min	Typ	Max	Units
Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V, I <sub>D</sub> =250uA	<b>BV<sub>DSS</sub></b>	30	-	-	<b>V</b>
BVDSS Temperature Coefficient	Reference to 25 °C, I <sub>D</sub> =1mA	<b>ΔBV<sub>DSS</sub>/ΔT<sub>J</sub></b>	-	0.027	-	<b>V/°C</b>
Static Drain-Source On-Resistance <sup>2</sup>	V <sub>GS</sub> =10V, I <sub>D</sub> =12A	<b>R<sub>DS(ON)</sub></b>	-	6.5	10	<b>mΩ</b>
	V <sub>GS</sub> =4.5V, I <sub>D</sub> =10A		-	10	13	<b>mΩ</b>
Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250uA	<b>V<sub>GS(th)</sub></b>	1.0	-	2.5	<b>V</b>
V <sub>GS(th)</sub> Temperature Coefficient		<b>ΔV<sub>GS(th)</sub></b>	-	-5.8	-	<b>mV/°C</b>
Drain-Source Leakage Current	V <sub>DS</sub> =24V, V <sub>GS</sub> =0V, T <sub>J</sub> =25°C	<b>I<sub>DSS</sub></b>	-	-	1	<b>uA</b>
	V <sub>DS</sub> =24V, V <sub>GS</sub> =0V, T <sub>J</sub> =55°C		-	-	5	
Gate-Source Leakage Current	V <sub>GS</sub> =±20V, V <sub>DS</sub> =0V	<b>I<sub>GSS</sub></b>	-	-	±100	<b>nA</b>
Forward Transconductance	V <sub>DS</sub> = 5V, I <sub>D</sub> = 15A	<b>g<sub>fs</sub></b>	-	9.8	-	<b>S</b>
Gate Resistance	V <sub>DS</sub> =0V, V <sub>GS</sub> =0V, f=1MHz	<b>R<sub>g</sub></b>	-	1.7	-	<b>Ω</b>
Total Gate Charge(4.5V)	V <sub>DS</sub> =20V V <sub>GS</sub> =4.5V I <sub>D</sub> =12A	<b>Q<sub>g</sub></b>	-	12.8	-	<b>nC</b>
Gate-Source Charge		<b>Q<sub>gs</sub></b>	-	3.3	-	
Gate-Drain Charge		<b>Q<sub>gd</sub></b>	-	6.5	-	
Turn-on delay time	V <sub>DD</sub> = 12V V <sub>GS</sub> = 10V R <sub>G</sub> = 3.3Ω I <sub>D</sub> = 5A	<b>t<sub>d(on)</sub></b>	-	4.5	-	<b>ns</b>
Rise Time		<b>T<sub>r</sub></b>	-	10.8	-	
Turn-Off Delay Time		<b>t<sub>d(OFF)</sub></b>	-	25.5	-	
Fall Time		<b>t<sub>f</sub></b>	-	9.6	-	
Input Capacitance	V <sub>DS</sub> =15V V <sub>GS</sub> =0V f=1MHz	<b>C<sub>iss</sub></b>	-	1317	-	<b>pF</b>
Output Capacitance		<b>C<sub>oss</sub></b>	-	163	-	
Reverse Transfer Capacitance		<b>C<sub>rss</sub></b>	-	131	-	
Continuous Source Current <sup>1,6</sup>	V <sub>G</sub> =V <sub>D</sub> =0V, Force Current	<b>I<sub>S</sub></b>	-	-	46	<b>A</b>
Pulsed Source Current <sup>2,6</sup>		<b>I<sub>SM</sub></b>	-	-	92	<b>A</b>
Diode Forward Voltage <sup>2</sup>	V <sub>GS</sub> =0V, I <sub>S</sub> =1A, T <sub>J</sub> =25°C	<b>V<sub>SD</sub></b>	-	-	1	<b>V</b>

Note :

- 1、 The data tested by surface mounted on a 1 inch 2 FR-4 board with 2OZ copper.
- 2、 The data tested by pulsed , pulse width .The EAS data shows Max. rating .
- 3、 The power dissipation is limited by 175°C junction temperature
- 4、 EAS condition: T<sub>J</sub>=25°C, V<sub>DD</sub>= 24V, V<sub>G</sub>= 10V, R<sub>G</sub>=25Ω, L=0.1mH, I<sub>AS</sub>= 34A
- 5、 The data is theoretically the same as I<sub>D</sub> and I<sub>DM</sub> , in real applications , should be limited by total power dissipation.

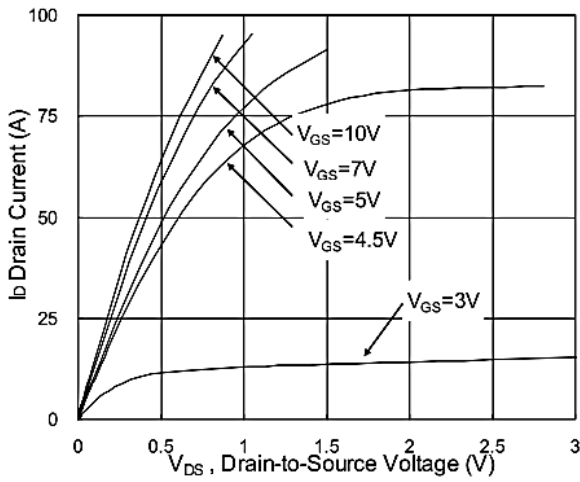
**P-Channel Electrical Characteristics (T<sub>J</sub>=25 °C, unless otherwise noted)**

Characteristics	Test Condition	Symbols	Min	Typ	Max	Units
Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V, I <sub>D</sub> =-250uA	<b>BV<sub>DSS</sub></b>	-30	-34	-	<b>V</b>
BVDSS Temperature Coefficient	Reference to 25°C, I <sub>D</sub> =-1mA	<b>ΔBV<sub>DSS</sub>/ΔT<sub>J</sub></b>	-	-0.0232	-	<b>V/°C</b>
Static Drain-Source On-Resistance	V <sub>GS</sub> =-10V, I <sub>D</sub> =-30A	<b>R<sub>DS(ON)</sub></b>	-	9.0	13	<b>mΩ</b>
	V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-15A		-	16	20	<b>mΩ</b>
Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =-250uA	<b>V<sub>GS(th)</sub></b>	-1.2	-1.4	-2.5	<b>V</b>
V <sub>GS(th)</sub> Temperature Coefficient		<b>ΔV<sub>GS(th)</sub></b>	-	4.6	-	<b>mV/°C</b>
Drain-Source Leakage Current	V <sub>DS</sub> =-24V, V <sub>GS</sub> =0V, T <sub>J</sub> =25°C	<b>I<sub>DSS</sub></b>	-	-	-1	<b>uA</b>
	V <sub>DS</sub> =-24V, V <sub>GS</sub> =0V, T <sub>J</sub> =55°C		-	-	-5	
Gate-Source Leakage Current	V <sub>GS</sub> =±20V, V <sub>DS</sub> =0V	<b>I<sub>GSS</sub></b>	-	-	±100	<b>nA</b>
Forward Transconductance	V <sub>DS</sub> = -5V, I <sub>D</sub> = -30A	<b>g<sub>fs</sub></b>	-	30	-	<b>S</b>
Gate Resistance	V <sub>DS</sub> =0V, V <sub>GS</sub> =0V, f=1MHz	<b>R<sub>g</sub></b>	-	9	-	<b>Ω</b>
Total Gate Charge(-4.5V)	V <sub>DS</sub> =-15V V <sub>GS</sub> =-4.5V I <sub>D</sub> =-15A	<b>Q<sub>g</sub></b>	-	22	-	<b>nC</b>
Gate-Source Charge		<b>Q<sub>gs</sub></b>	-	8.7	-	
Gate-Drain Charge		<b>Q<sub>gd</sub></b>	-	7.2	-	
Turn-on delay time	V <sub>DD</sub> =-15V V <sub>GS</sub> =-10V R <sub>G</sub> = 3.3Ω I <sub>D</sub> =-15A	<b>t<sub>d(on)</sub></b>	-	8	-	<b>ns</b>
Rise Time		<b>T<sub>r</sub></b>	-	73.7	-	
Turn-Off Delay Time		<b>t<sub>d(OFF)</sub></b>	-	61.8	-	
Fall Time		<b>t<sub>f</sub></b>	-	24.4	-	
Input Capacitance	V <sub>DS</sub> =-15V V <sub>GS</sub> =0V f=1MHz	<b>C<sub>iss</sub></b>	-	2215	-	<b>pF</b>
Output Capacitance		<b>C<sub>oss</sub></b>	-	310	-	
Reverse Transfer Capacitance		<b>C<sub>rss</sub></b>	-	237	-	
Continuous Source Current	V <sub>G</sub> =V <sub>D</sub> =0V, Force Current	<b>I<sub>S</sub></b>	-	-	-42	<b>A</b>
Pulsed Source Current		<b>I<sub>SM</sub></b>	-	-	-130	<b>A</b>
Diode Forward Voltage	V <sub>GS</sub> =0V, I <sub>S</sub> =-1A, T <sub>J</sub> =25°C	<b>V<sub>SD</sub></b>	-	-	-1	<b>A</b>
Reverse Recovery Time	I <sub>F</sub> =-15A, dI/dt=100A/μs, T <sub>J</sub> =25°C	<b>t<sub>rr</sub></b>	-	19	-	<b>nS</b>
Reverse Recovery Charge		<b>Q<sub>rr</sub></b>	-	9	-	<b>nC</b>

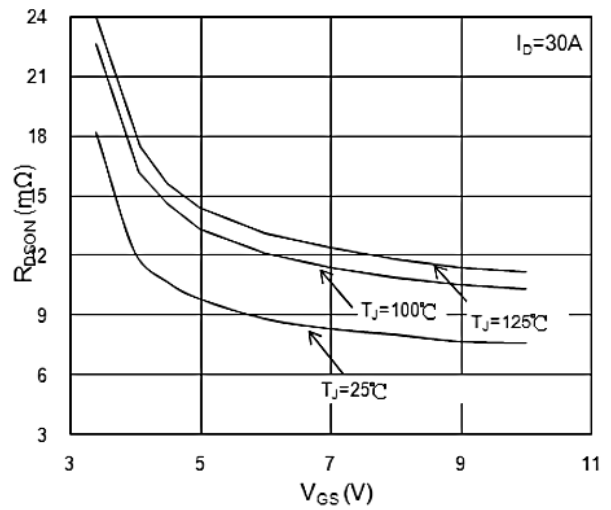
Note :

- 1、 The data tested by surface mounted on a 1 inch 2 FR-4 board with 2OZ copper.
- 2、 The data tested by pulsed , pulse width .The EAS data shows Max. rating .
- 3、 The power dissipation is limited by 175°C junction temperature
- 4、 EAS condition: T<sub>J</sub>=25°C, V<sub>DD</sub>= -24V, V<sub>G</sub>= -10V, R<sub>G</sub>=7Ω, L=0.1mH, I<sub>AS</sub>= -50A
- 5、 The data is theoretically the same as I<sub>D</sub> and I<sub>DM</sub> , in real applications , should be limited by total power dissipation.

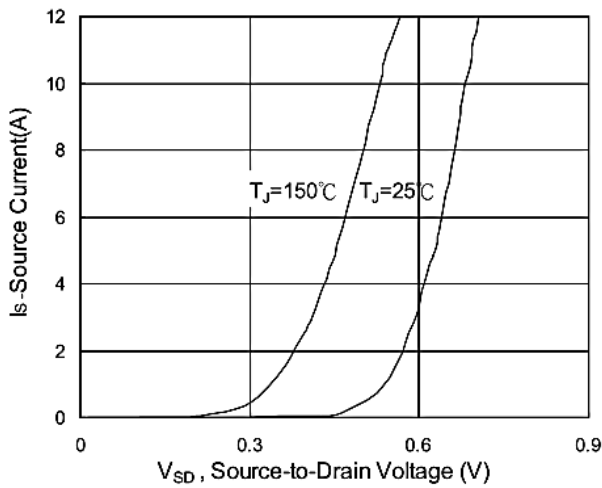
**N-Typical Characteristics**



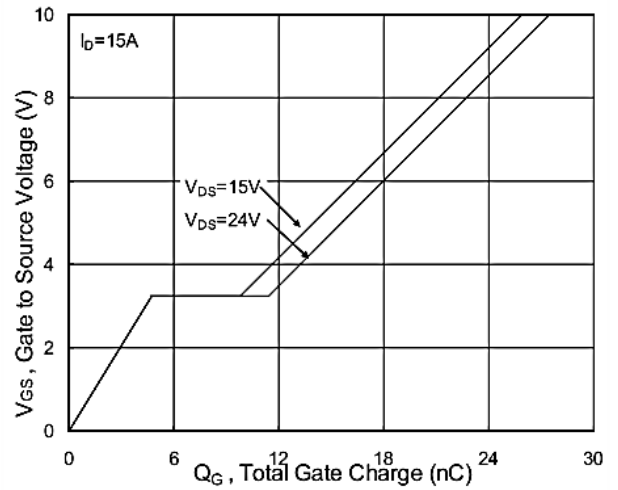
**Fig.1 Typical Output Characteristics**



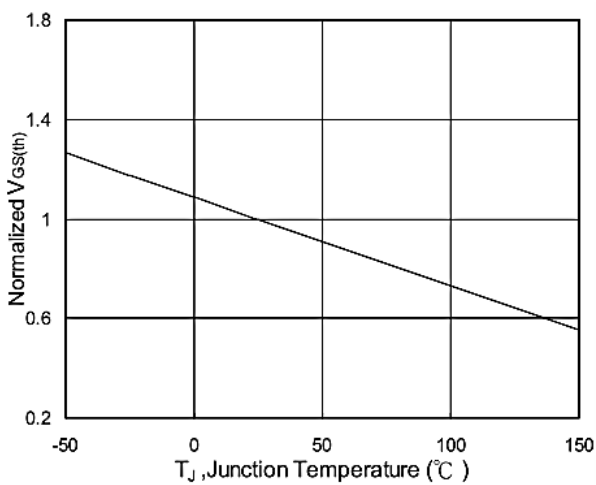
**Fig.2 On-Resistance vs. Gate-Source**



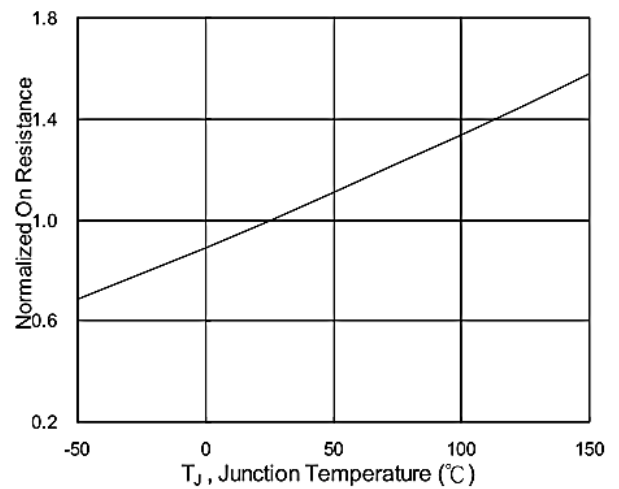
**Fig.3 Forward Characteristics of reverse**



**Fig.4 Gate-Charge Characteristics**

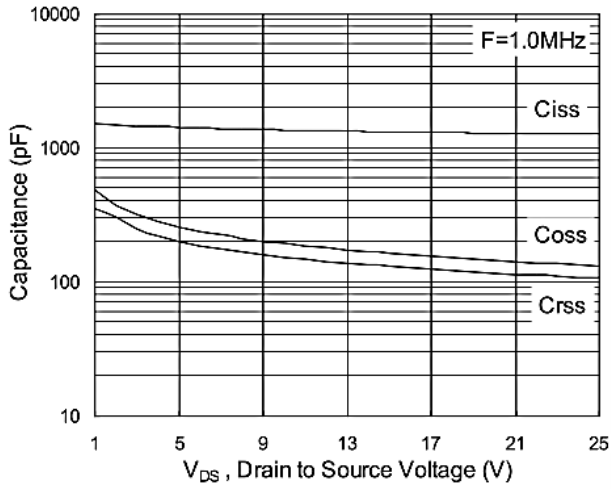


**Fig.5 Normalized  $V_{GS(th)}$  vs.  $T_J$**

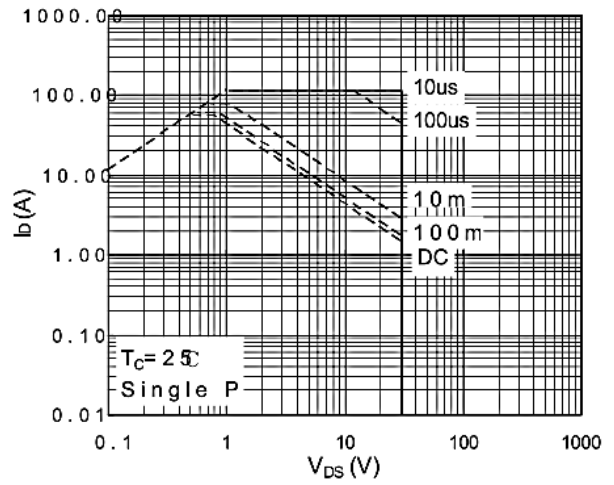


**Fig.6 Normalized  $R_{DS(on)}$  vs.  $T_J$**

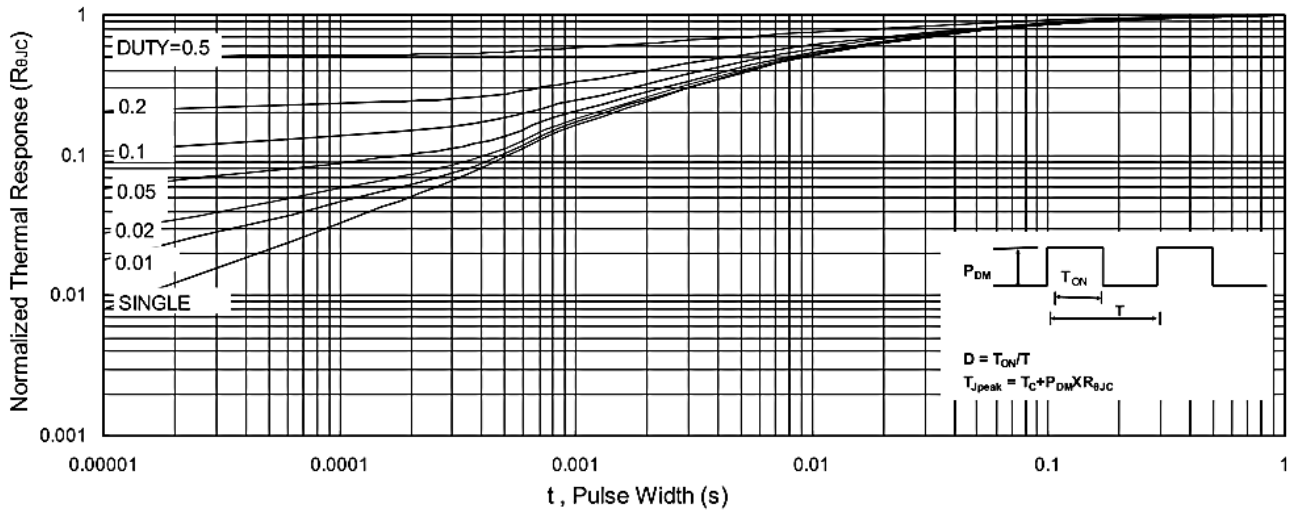
**Ratings and Characteristic Curves**



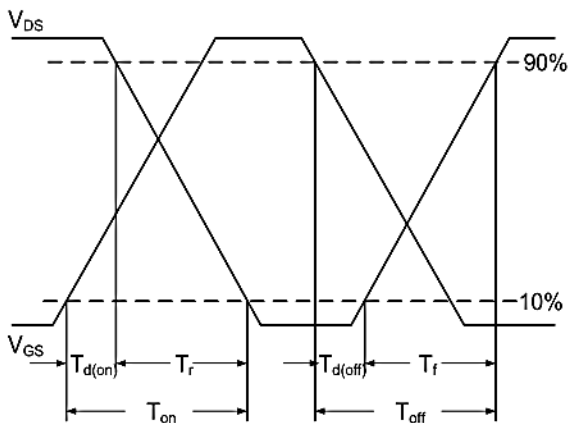
**Fig.7 Capacitance**



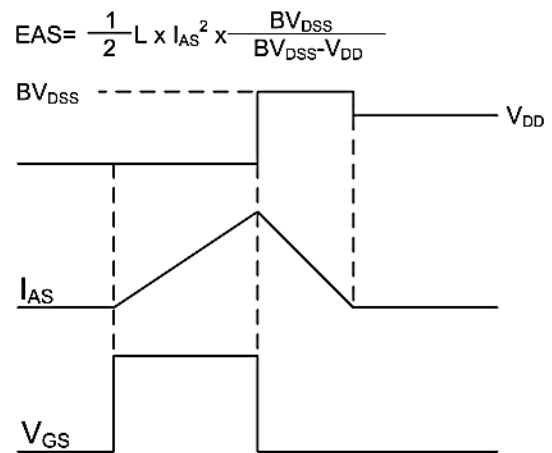
**Fig.8 Safe Operating Area**



**Fig.9 Normalized Maximum Transient Thermal Impedance**



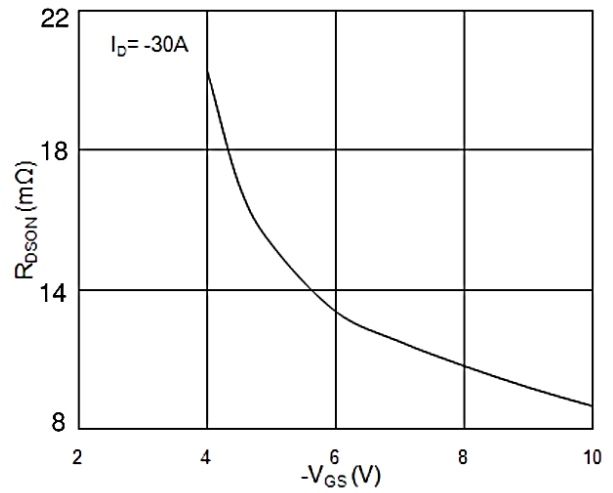
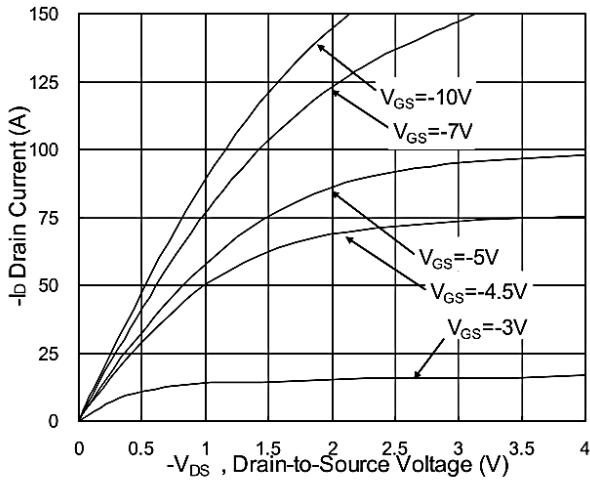
**Fig.10 Switching Time Waveform**



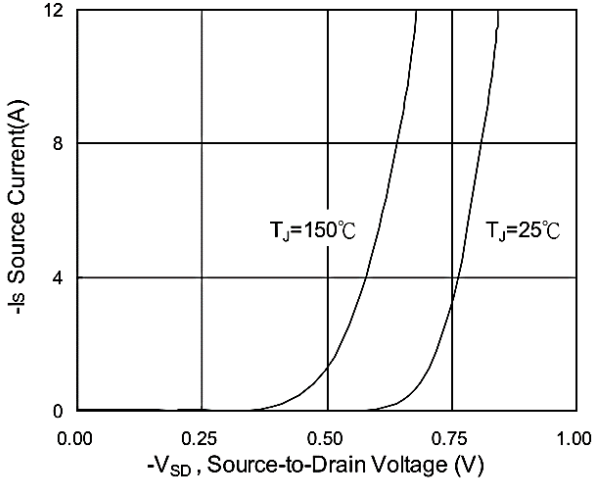
**Fig.17 Unclamped Inductive Switching Waveform**

**Ratings and Characteristic Curves**

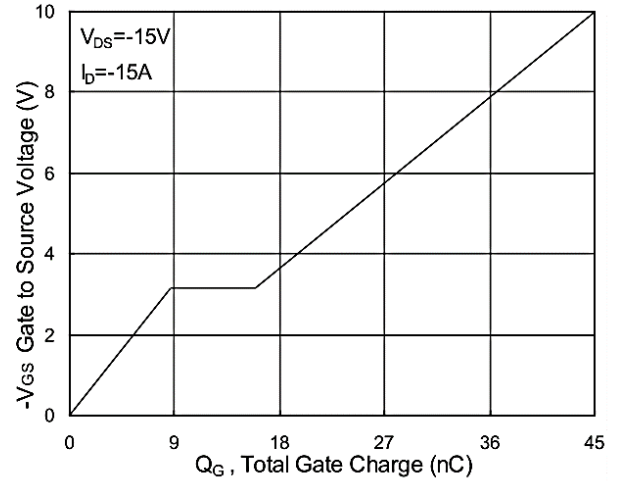
**P-Typical Characteristics**



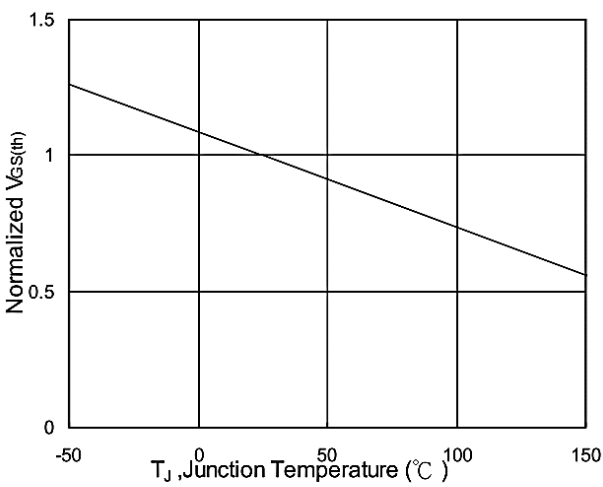
**Fig.1 Typical Output Characteristics**



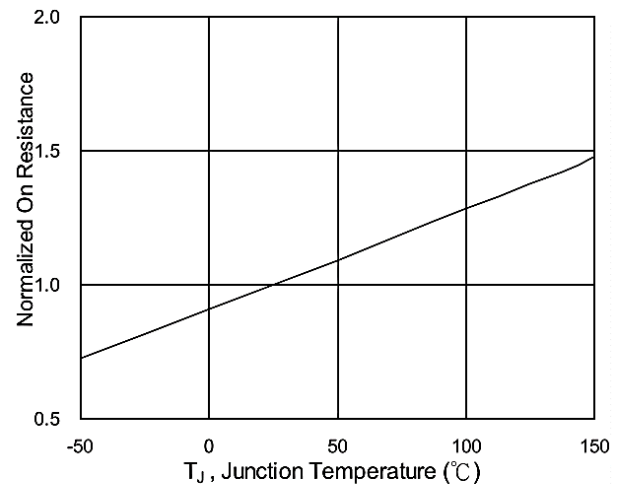
**Fig.2 On-Resistance vs. G-S Voltage**



**Fig.3 Forward Characteristics of Reverse**



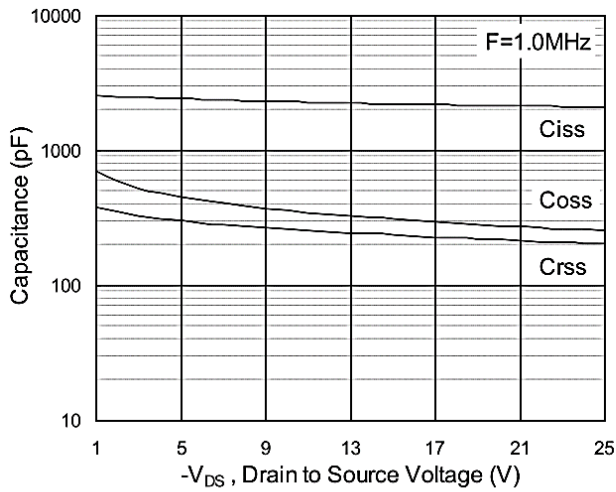
**Fig.4 Gate-Charge Characteristics**



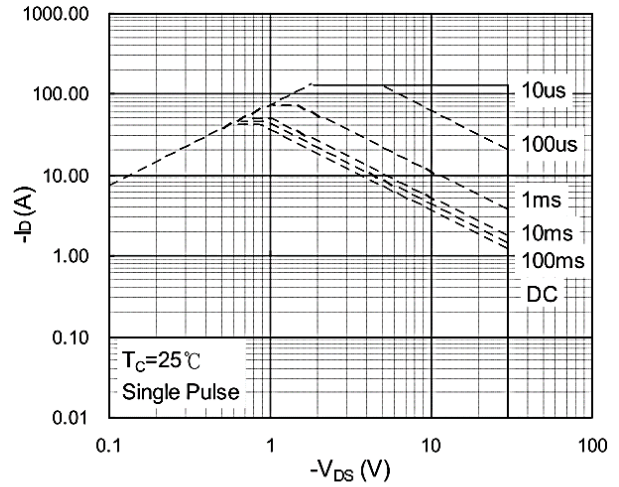
**Fig.5 Normalized  $V_{GS(th)}$  vs.  $T_J$**

**Fig.6 Normalized  $R_{DS(on)}$  vs.  $T_J$**

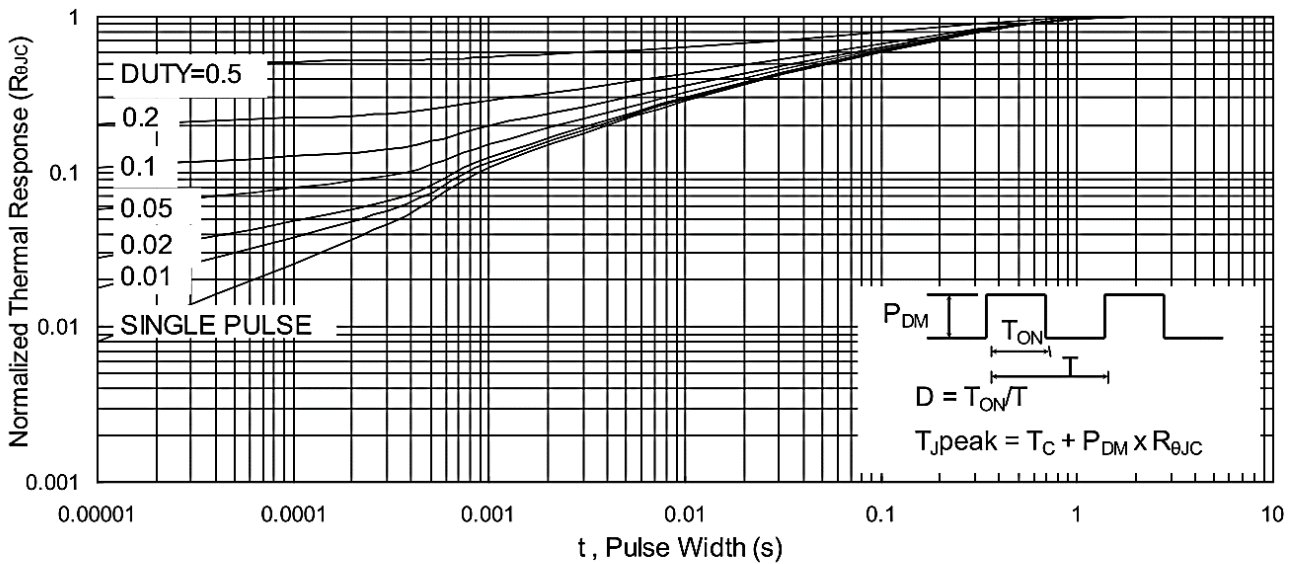
**Ratings and Characteristic Curves**



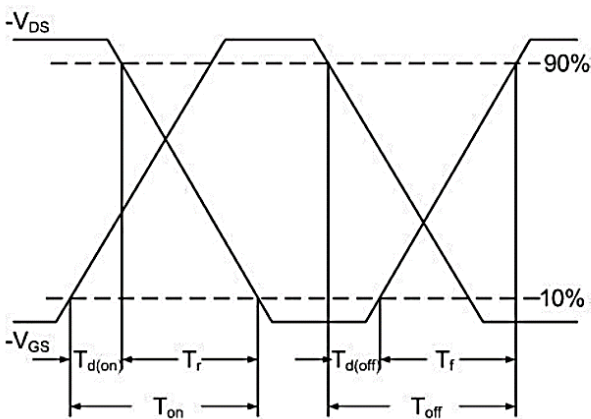
**Fig.7 Capacitance**



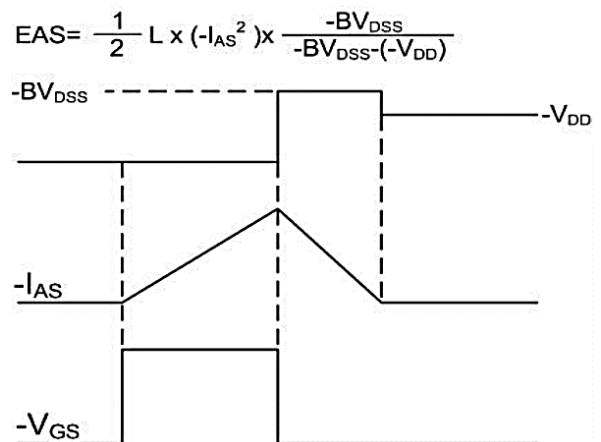
**Fig.8 Safe Operating Area**



**Fig.9 Normalized Maximum Transient Thermal Impedance**

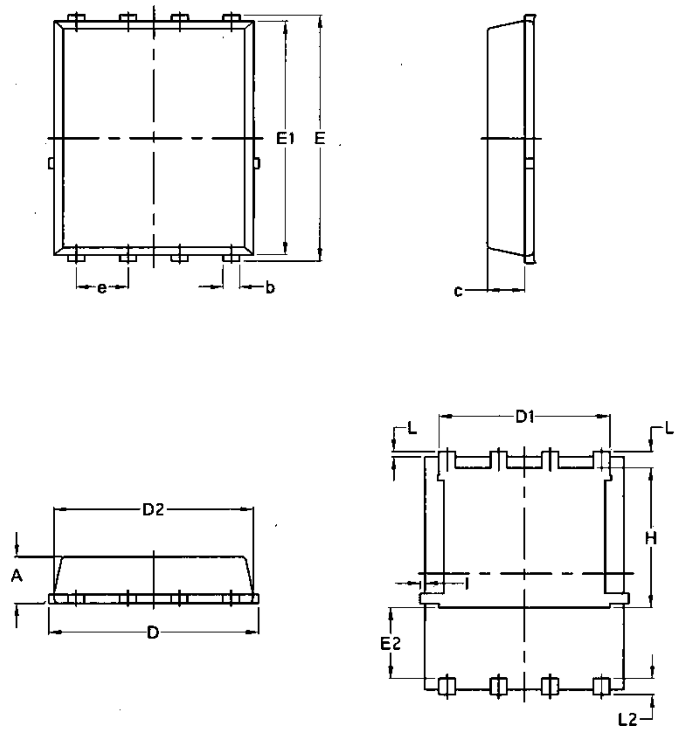


**Fig.10 Switching Time Waveform**



**Fig.11 Unclamped Inductive Switching Waveform**

**PDFN5\*6-8L**



Symbol	Common			
	mm		Inch	
	Min	Max	Min	Max
A	1.03	1.17	0.0406	0.0461
b	0.34	0.48	0.0134	0.0189
c	0.824	0.0970	0.0324	0.082
D	4.80	5.40	0.1890	0.2126
D1	4.11	4.31	0.1618	0.1697
D2	4.80	5.00	0.1890	0.1969
E	5.95	6.15	0.2343	0.2421
E1	5.65	5.85	0.2224	0.2303
E2	1.60	/	0.0630	/
e	1.27 BSC		0.05 BSC	
L	0.05	0.25	0.0020	0.0098
L1	0.38	0.50	0.0150	0.0197
L2	0.38	0.50	0.0150	0.0197
H	3.30	3.50	0.1299	0.1378
I	/	0.18	/	0.0070